



# RF Power LDMOS Transistors

## Enhancement-Mode Lateral MOSFETs

These 90 W RF power LDMOS transistors are designed for wideband RF power amplifiers covering the frequency range of 470 to 860 MHz.

- Typical Performance (Narrowband Test Circuit):  $V_{DD} = 50$  Vdc,  $I_{DQ} = 350$  mA, 64 QAM, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF.

Signal Type	$P_{out}$ (W)	f (MHz)	$G_{ps}$ (dB)	$\eta_D$ (%)	ACPR (dBc)
DVB-T (8k OFDM)	18 Avg.	860	22.0	28.5	-62.0

- Typical Performance (Broadband Reference Circuit):  $V_{DD} = 50$  Vdc,  $I_{DQ} = 450$  mA, 64 QAM, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF.

Signal Type	$P_{out}$ (W)	f (MHz)	$G_{ps}$ (dB)	$\eta_D$ (%)	Output Signal PAR (dB)	IMD Shoulder (dBc)
DVB-T (8k OFDM)	18 Avg.	470	21.6	26.8	8.6	-31.8
		650	22.9	28.0	8.7	-34.4
		860	21.9	28.3	7.9	-29.2

### Features

- Capable of Handling 10:1 VSWR, All Phase Angles @ 50 Vdc, 860 MHz, 90 W CW Output Power
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Input Matched for Ease of Use
- Qualified Up to a Maximum of 50  $V_{DD}$  Operation
- Integrated ESD Protection
- Excellent Thermal Stability
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- 225°C Capable Plastic Package
- In Tape and Reel. R1 Suffix = 50 Units, 44 mm Tape Width, 13-inch Reel.

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +120	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_C$	150	°C
Operating Junction Temperature (1,2)	$T_J$	225	°C

**Table 2. Thermal Characteristics**

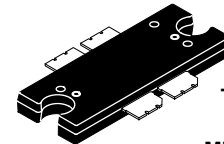
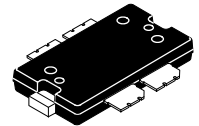
Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 76°C, 18 W CW, 50 Vdc, $I_{DQ} = 350$ mA, 860 MHz Case Temperature 80°C, 90 W CW, 50 Vdc, $I_{DQ} = 350$ mA, 860 MHz	$R_{\theta JC}$	0.79 0.82	°C/W

- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

## MMRF1018NR1 MMRF1018NBR1

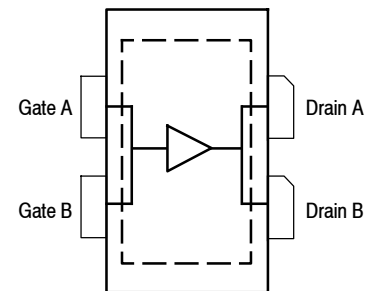
470-860 MHz, 90 W, 50 V  
BROADBAND  
RF POWER LDMOS TRANSISTORS

TO-270WB-4  
PLASTIC  
MMRF1018NR1



TO-272WB-4  
PLASTIC  
MMRF1018NBR1

PARTS ARE SINGLE-ENDED



(Top View)

Note: Exposed backside of the package is the source terminal for the transistor.

**Figure 1. Pin Connections**

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (2001-4000 V)
Machine Model (per EIA/JESD22-A115)	B (201-400 V)
Charge Device Model (per JESD22-C101)	IV (>1000 V)

**Table 4. Moisture Sensitivity Level**

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

**Table 5. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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**Off Characteristics**

Gate-Source Leakage Current ( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )	$I_{GSS}$	—	—	0.5	$\mu\text{Adc}$
Drain-Source Breakdown Voltage ( $I_D = 50\text{ mA}$ , $V_{GS} = 0\text{ Vdc}$ )	$V_{(BR)DSS}$	120	—	—	Vdc
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 100\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ )	$I_{DSS}$	—	—	20	$\mu\text{Adc}$

**On Characteristics**

Gate Threshold Voltage ( $V_{DS} = 10\text{ Vdc}$ , $I_D = 200\ \mu\text{Adc}$ )	$V_{GS(th)}$	0.9	1.6	2.4	Vdc
Gate Quiescent Voltage ( $V_{DD} = 50\text{ Vdc}$ , $I_D = 350\text{ mA}$ , Measured in Functional Test)	$V_{GS(Q)}$	2.0	2.7	3.5	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10\text{ Vdc}$ , $I_D = 0.5\text{ Adc}$ )	$V_{DS(on)}$	—	0.2	—	Vdc

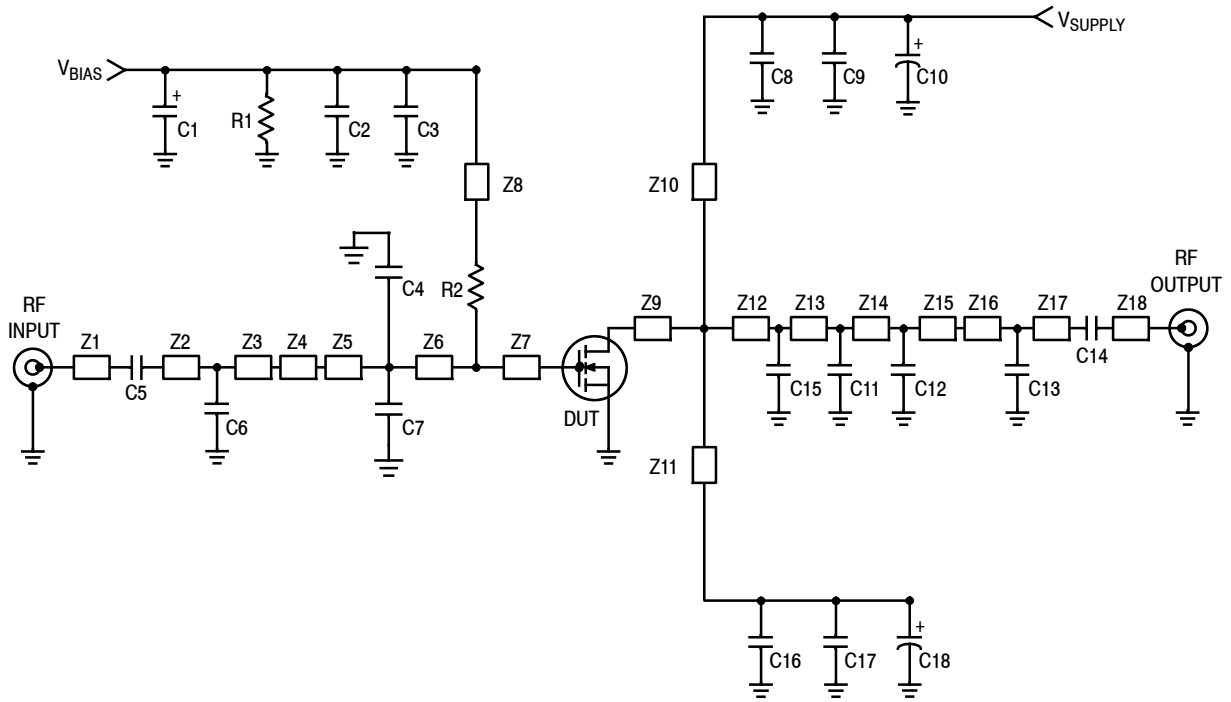
**Dynamic Characteristics**

Reverse Transfer Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{rss}$	—	41	—	pF
Output Capacitance ( $V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$ )	$C_{oss}$	—	65.4	—	pF
Input Capacitance (1) ( $V_{DS} = 50\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz)	$C_{iss}$	—	591	—	pF

**Functional Tests** (In Freescale DVB-T Narrowband Test Fixture, 50 ohm system)  $V_{DD} = 50\text{ Vdc}$ ,  $I_{DQ} = 350\text{ mA}$ ,  $P_{out} = 18\text{ W Avg.}$ ,  $f = 860\text{ MHz}$ , DVB-T (8k OFDM) Single Channel. ACPR measured in 7.61 MHz Channel Bandwidth @  $\pm 4\text{ MHz}$  Offset @ 4 kHz Bandwidth.

Power Gain	$G_{ps}$	21.0	22.0	24.0	dB
Drain Efficiency	$\eta_D$	27.5	28.5	—	%
Adjacent Channel Power Ratio	ACPR	—	-62.0	-60.0	dBc
Input Return Loss	IRL	—	-14	-9	dB

1. Part internally input matched.



Z1	0.266" × 0.067" Microstrip	Z10, Z11	1.292" × 0.079" Microstrip
Z2	0.331" × 0.067" Microstrip	Z12	0.680" × 0.571" Microstrip
Z3	0.598" × 0.067" Microstrip	Z13	0.132" × 0.117" Microstrip
Z4	0.315" × 0.276" Microstrip	Z14	0.705" × 0.117" Microstrip
Z5	0.054" × 0.669" Microstrip	Z15	0.159" × 0.117" Microstrip
Z6	0.419" × 0.669" Microstrip	Z16	0.140" × 0.067" Microstrip
Z7	0.256" × 0.669" Microstrip	Z17	0.077" × 0.067" Microstrip
Z8	0.986" × 0.071" Microstrip	Z18	0.163" × 0.067" Microstrip
Z9	0.201" × 0.571" Microstrip		

**Figure 2. MMRF1018NR1(NBR1) 860 MHz Narrowband Test Circuit Schematic**

**Table 6. MMRF1018NR1(NBR1) 860 MHz Narrowband Test Circuit Component Designations and Values**

Part	Description	Part Number	Manufacturer
C1	22 $\mu$ F, 35 V Tantalum Capacitor	T491X226K035AT	Kemet
C2, C9, C17	10 $\mu$ F, 50 V Chip Capacitors	GRM55DR61H106KA88L	Murata
C3, C5, C8, C14, C16	43 pF Chip Capacitors	ATC100B430JT500XT	ATC
C4	6.2 pF Chip Capacitor	ATC100B6R2BT500XT	ATC
C6	2.2 pF Chip Capacitor	ATC100B2R2JT500XT	ATC
C7	9.1 pF Chip Capacitor	ATC100B9R1CT500XT	ATC
C10, C18	220 $\mu$ F, 100 V Electrolytic Capacitors	EEVFK2A221M	Panasonic-ECG
C11, C15	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C12	3.0 pF Chip Capacitor	ATC100B3R0CT500XT	ATC
C13	0.7 pF Chip Capacitor	ATC100B0R7BT500XT	ATC
R1	10 k $\Omega$ , 1/4 W Chip Resistor	CRCW120610KOJNEA	Vishay
R2	10 $\Omega$ , 1/4 W Chip Resistor	CRCW120610ROJNEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	RF-35	Taconic

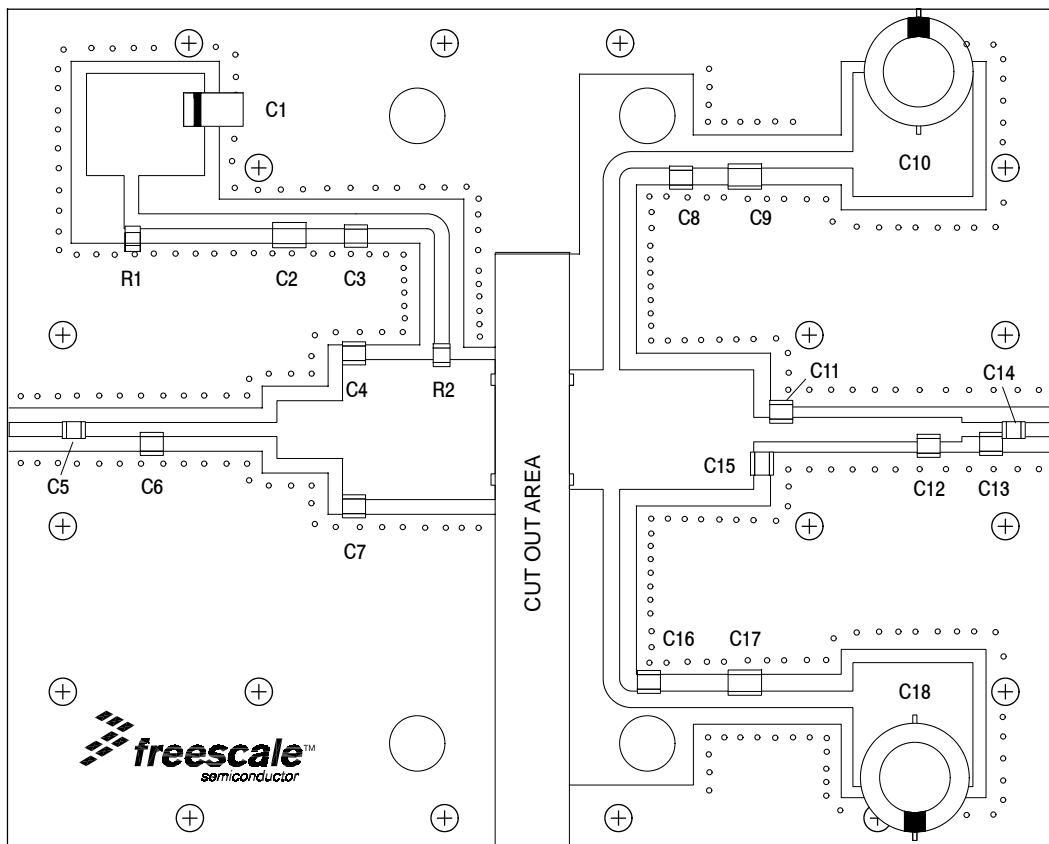
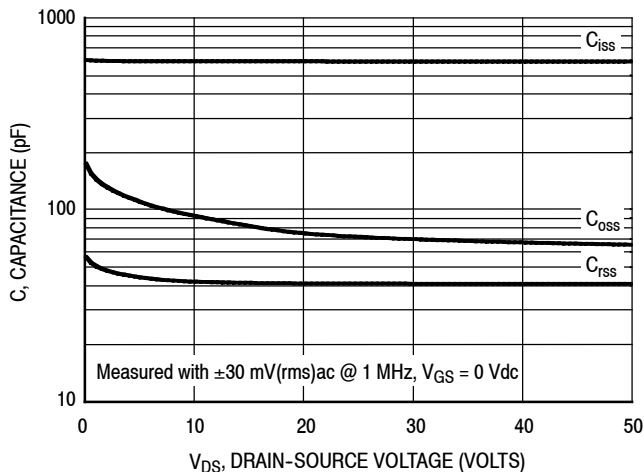
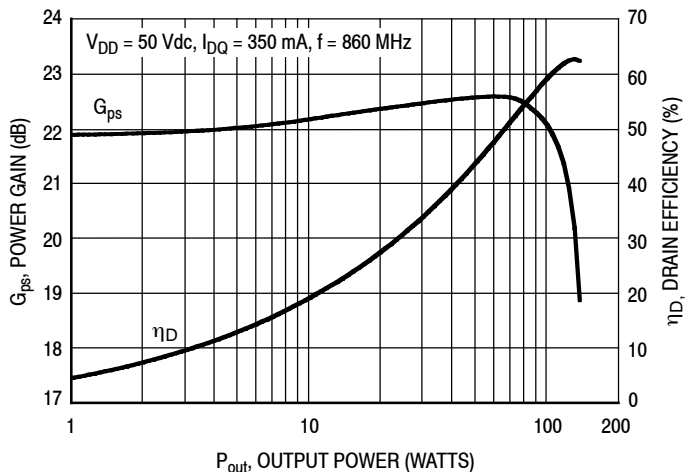


Figure 3. MMRF1018NR1(NBR1) 860 MHz Narrowband Test Circuit Component Layout

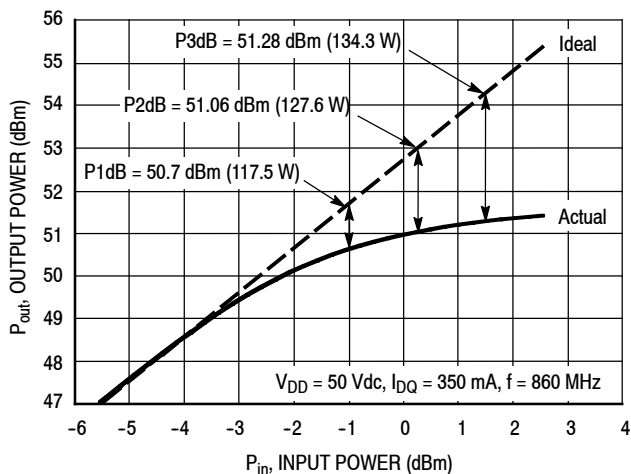
## TYPICAL CHARACTERISTICS



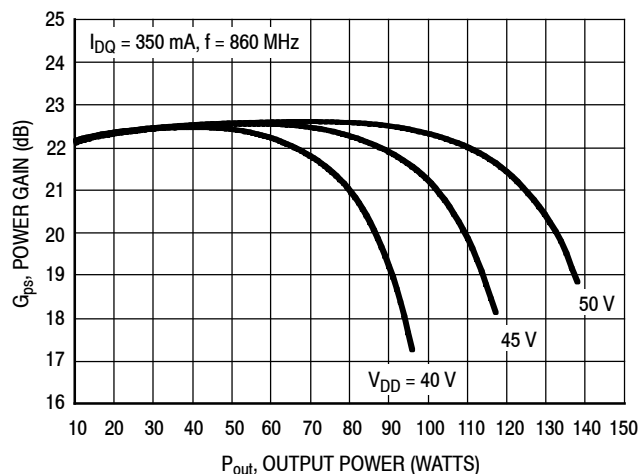
**Figure 4. Capacitance versus Drain-Source Voltage**



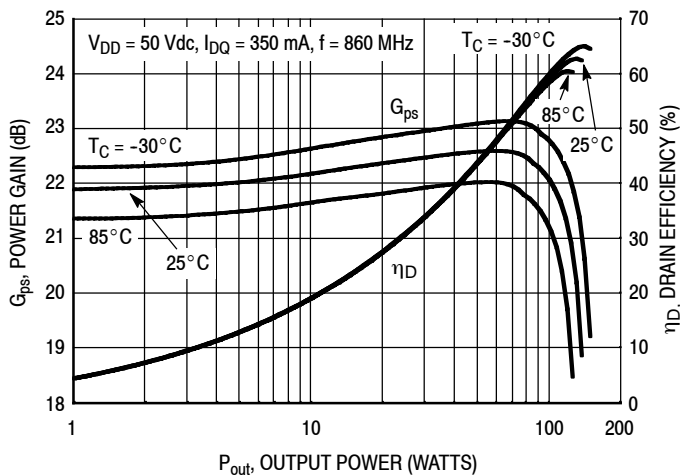
**Figure 5. CW Power Gain and Drain Efficiency versus Output Power (Narrowband Test Circuit)**



**Figure 6. CW Output Power versus Input Power (Narrowband Test Circuit)**



**Figure 7. CW Power Gain versus Output Power (Narrowband Test Circuit)**



**Figure 8. CW Power Gain and Drain Efficiency versus Output Power (Narrowband Test Circuit)**

TYPICAL CHARACTERISTICS — TWO-TONE (NARROWBAND TEST CIRCUIT)

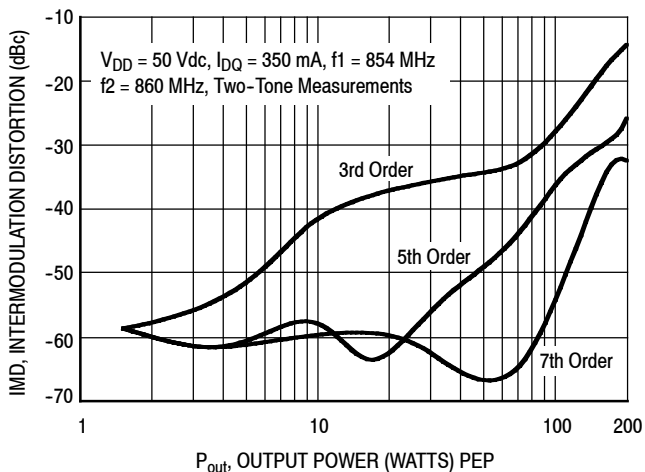


Figure 9. Intermodulation Distortion Products versus Output Power

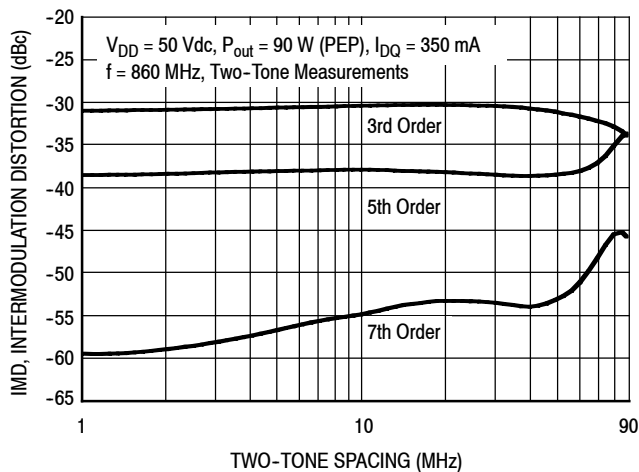


Figure 10. Intermodulation Distortion Products versus Two-Tone Spacing

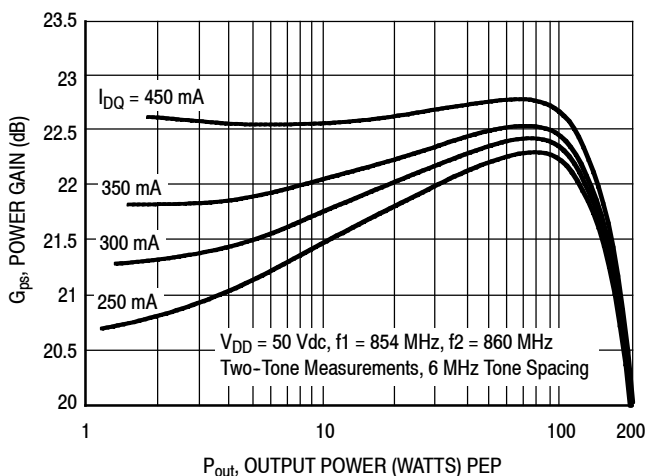


Figure 11. Two-Tone Power Gain versus Output Power

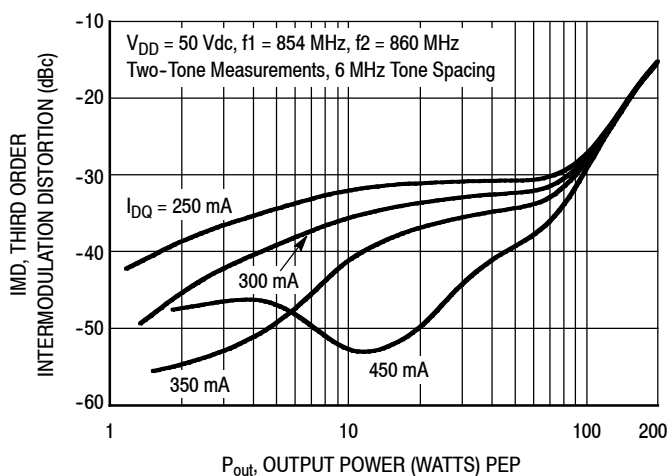
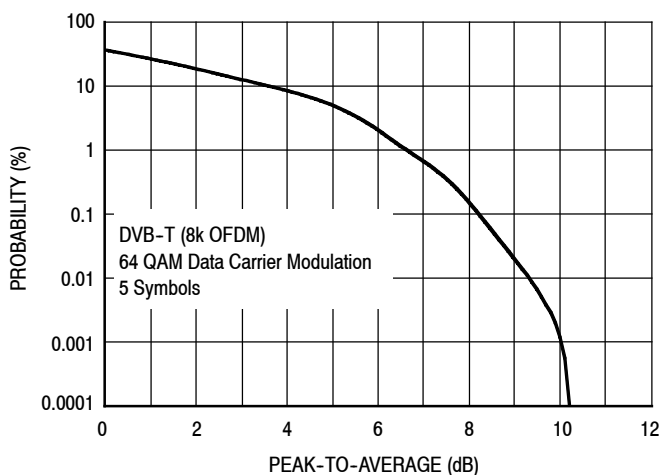
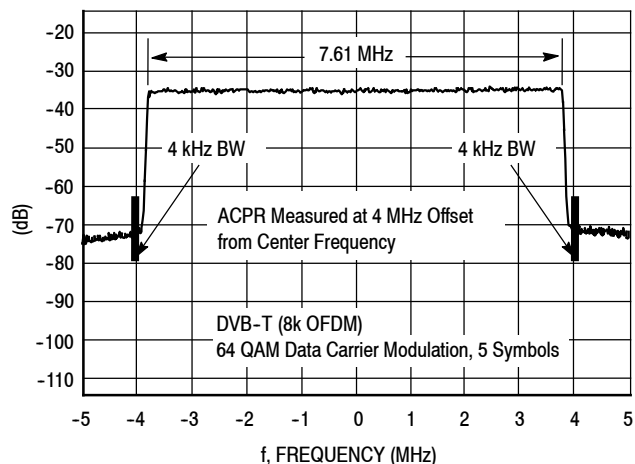


Figure 12. Third Order Intermodulation Distortion versus Output Power

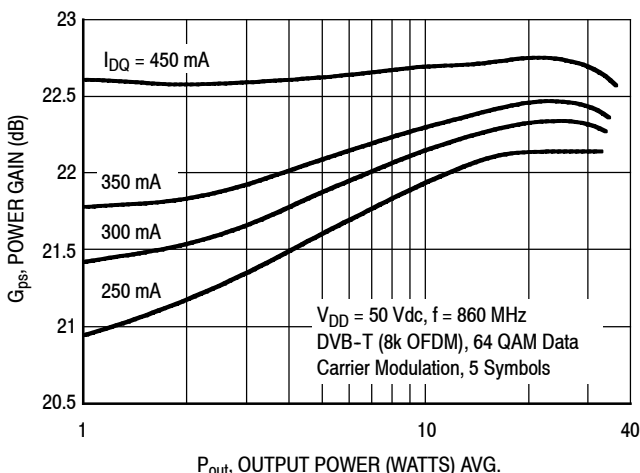
## TYPICAL CHARACTERISTICS — DVB-T (8k OFDM)



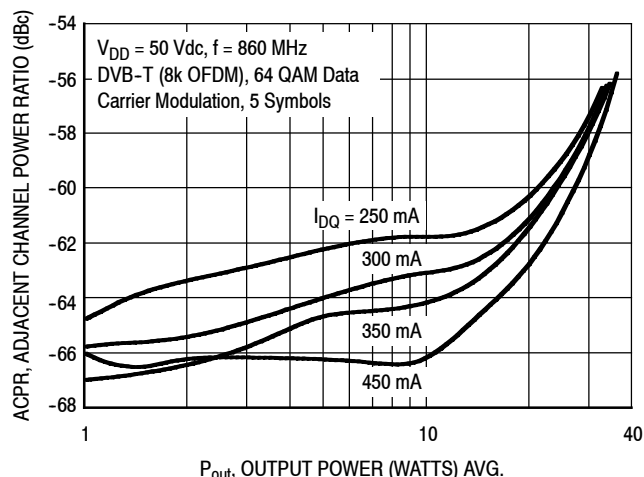
**Figure 13. Single-Carrier DVB-T (8k OFDM)**



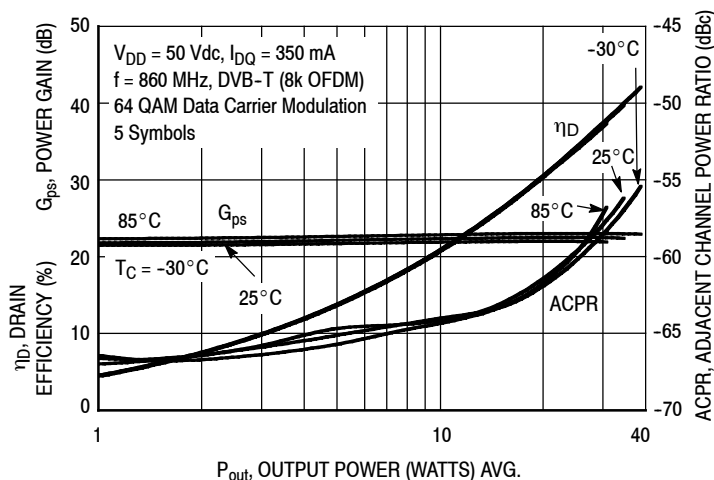
**Figure 14. DVB-T (8k OFDM) Spectrum**



**Figure 15. Single-Carrier DVB-T (8k OFDM) Power Gain versus Output Power (Narrowband Test Circuit)**

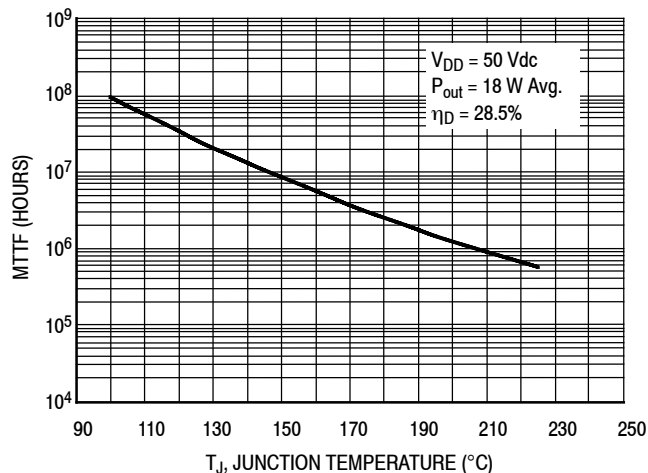


**Figure 16. Single-Carrier DVB-T (8k OFDM) ACPR versus Output Power (Narrowband Test Circuit)**



**Figure 17. Single-Carrier DVB-T (8k OFDM) Drain Efficiency, Power Gain and ACPR versus Output Power (Narrowband Test Circuit)**

### TYPICAL CHARACTERISTICS



MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

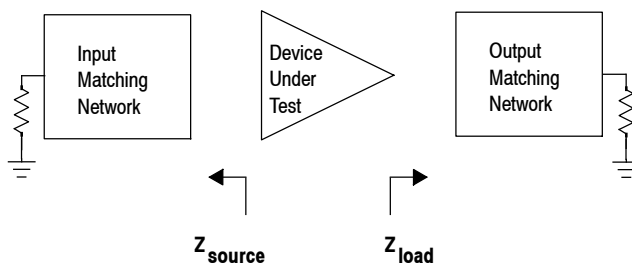
**Figure 18. MTTF versus Junction Temperature - CW**

$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 350 \text{ mA}$ ,  $P_{out} = 18 \text{ W Average}$

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
860	$1.58 - j0.89$	$3.51 - j3.98$

$Z_{source}$  = Test circuit impedance as measured from gate to ground.

$Z_{load}$  = Test circuit impedance as measured from drain to ground.



**Figure 19. Series Equivalent Source and Load Impedance (Narrowband Test Circuit)**



## 470-860 MHz BROADBAND REFERENCE CIRCUIT

$V_{DD} = 50 \text{ Vdc}$ ,  $I_{DQ} = 450 \text{ mA}$ , Channel Bandwidth = 8 MHz, Input Signal PAR = 9.5 dB @ 0.01% Probability on CCDF.

Signal Type	$P_{out}$ (W)	f (MHz)	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	IMD Shoulder (dBc)
DVB-T (8k OFDM)	4.5 Avg.	470	21.5	11.6	9.9	-37.5
		650	22.8	11.8	9.9	-41.7
		860	21.8	11.9	9.8	-40.3
	9 Avg.	470	21.6	18.2	9.5	-37.4
		650	22.8	18.6	9.7	-40.2
		860	21.8	18.9	9.5	-39.0
	18 Avg.	470	21.6	26.8	8.6	-31.8
		650	22.9	28.0	8.7	-34.4
		860	21.9	28.3	7.9	-29.2

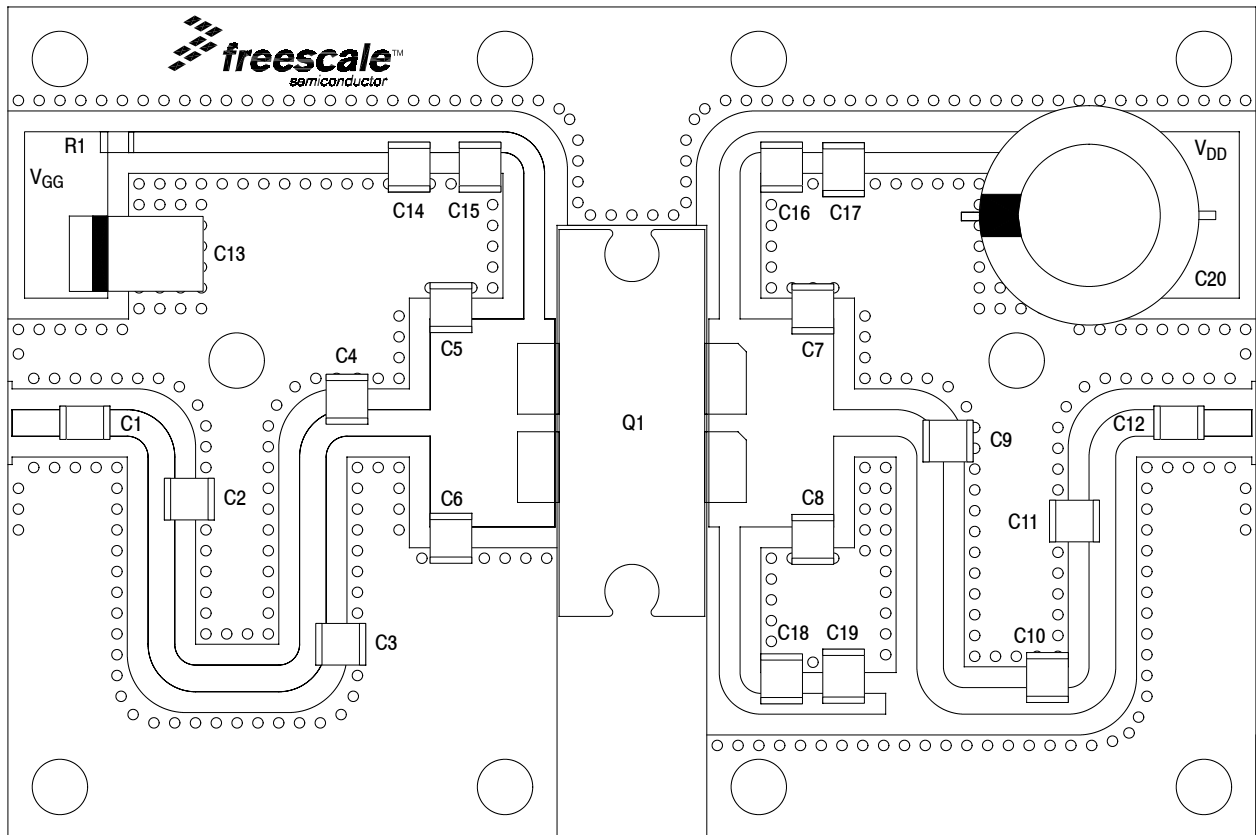


Figure 20. MMRF1018NR1(NBR1) 470-860 MHz Broadband 2" x 3" Compact Reference Circuit Component Layout

## 470-860 MHz BROADBAND REFERENCE CIRCUIT

**Table 7. MMRF1018NR1(NBR1) 470-860 MHz Broadband 2" x 3" Reference Circuit Component Designations and Values**

Part	Description	Part Number	Manufacturer
C1, C12	100 pF Chip Capacitors	ATC100B101JT500XT	ATC
C2	1.8 pF Chip Capacitor	ATC100B1R8BT500XT	ATC
C3	6.2 pF Chip Capacitor	ATC100B6R2BT500XT	ATC
C4, C5, C6	13 pF Chip Capacitors	ATC100B130JT500XT	ATC
C7, C8, C11	2.2 pF Chip Capacitors	ATC100B2R2JT500XT	ATC
C9	15 pF Chip Capacitor	ATC100B150JT500XT	ATC
C10	3.9 pF Chip Capacitor	ATC100B3R9CT500XT	ATC
C13	47 $\mu$ F, 16 V Tantalum Capacitor	T491D476K016AS	Kemet
C14, C17, C19	2.2 $\mu$ F, 100 V Chip Capacitors	C3225X7R2A225KT	TDK
C15, C16, C18	220 pF Chip Capacitors	ATC100B221JT200XT	ATC
C20	470 $\mu$ F, 63 V Electrolytic Capacitor	MCGPR63V477M13X26-RH	Multicomp
Q1	RF High Power Transistor	MRF6V3090NBR1	Freescale
R1	10 $\Omega$ , 1/4 W Chip Resistor	CRCW120610RJ	Vishay
PCB	Rogers RO4350B, 0.030", $\epsilon_r = 3.66$	—	MTL

TYPICAL CHARACTERISTICS — 470-860 MHz BROADBAND REFERENCE CIRCUIT

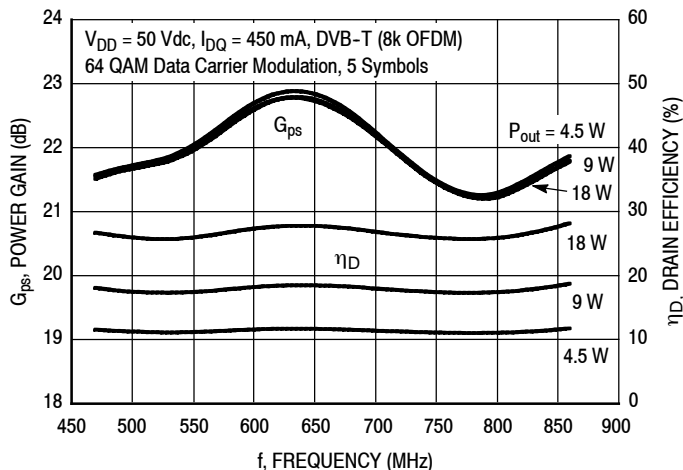
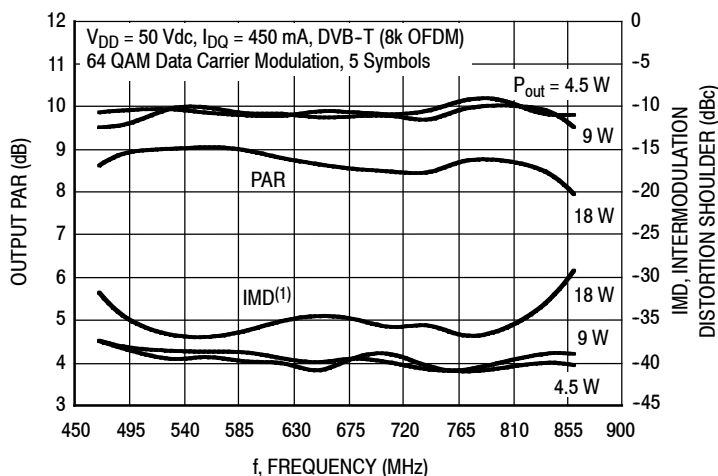


Figure 21. Single-Carrier DVB-T (8k OFDM) Power Gain and Drain Efficiency versus Frequency (Broadband Reference Circuit)



(1) Intermodulation distortion shoulder measurement made using delta marker at 4.2 MHz offset from center frequency.

Figure 22. Single-Carrier DVB-T (8k OFDM) Output PAR and IMD Shoulder versus Frequency (Broadband Reference Circuit)

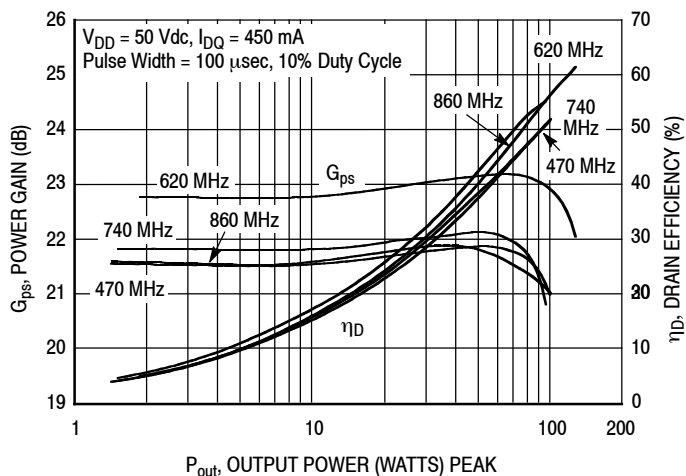
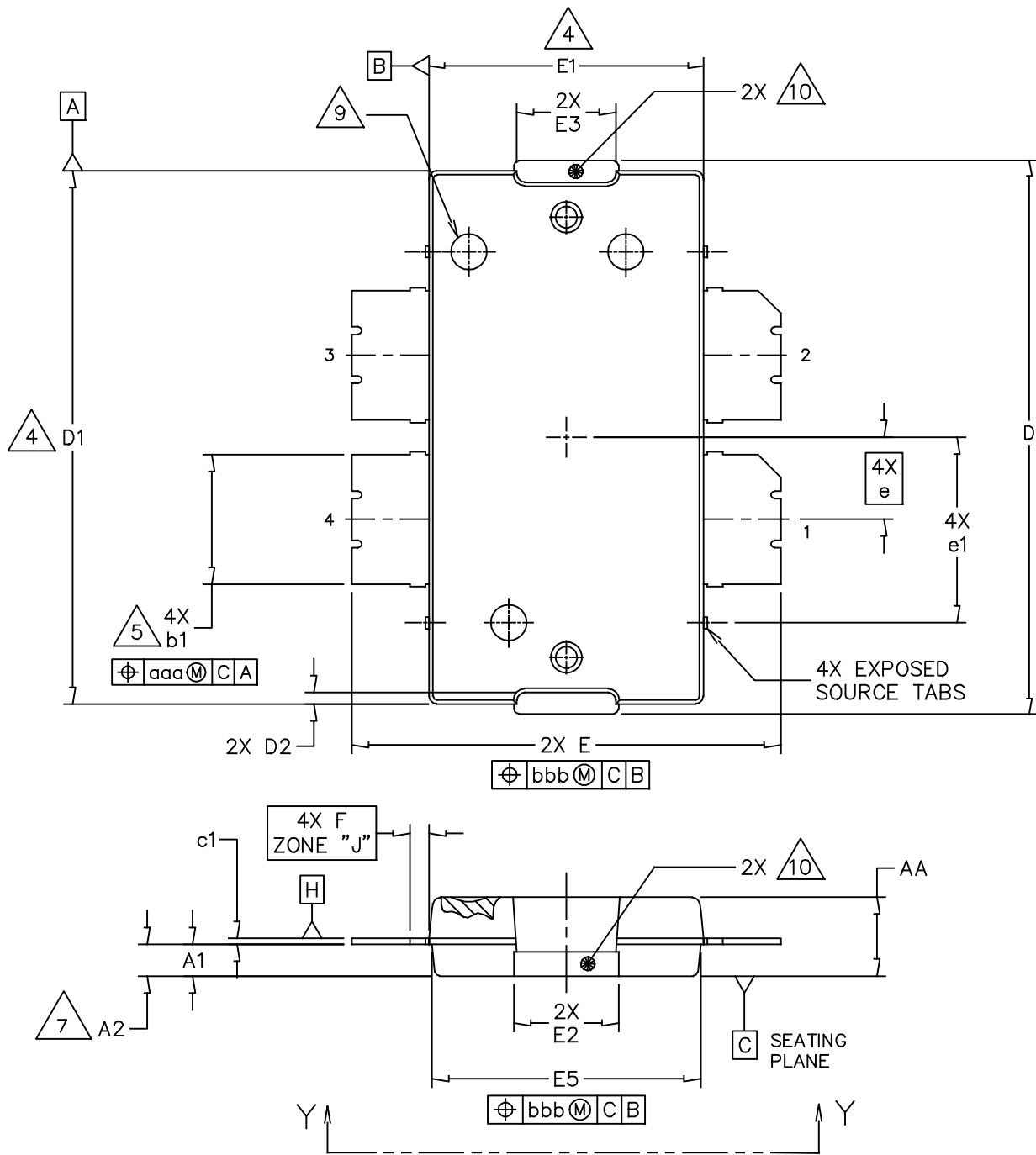
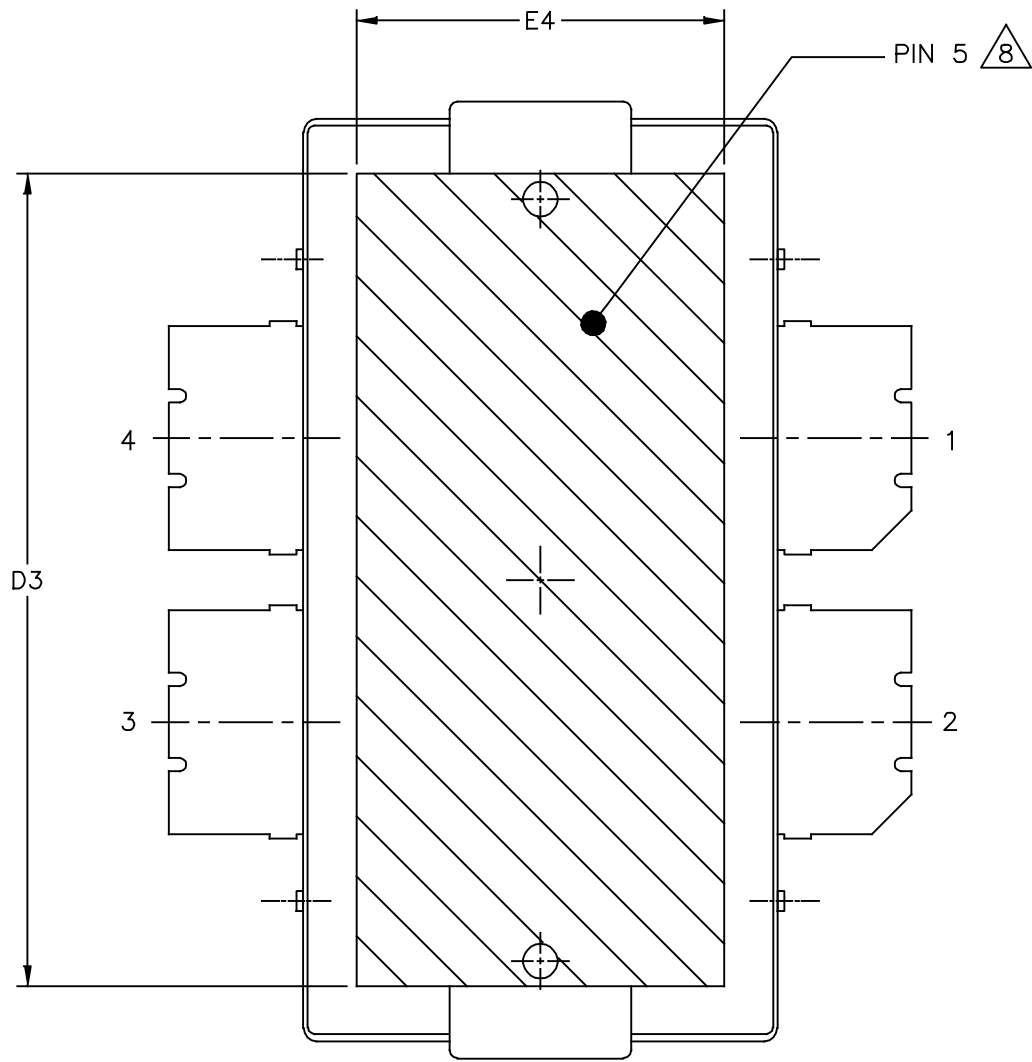


Figure 23. Power Gain and Drain Efficiency versus Output Power (Broadband Reference Circuit)

### PACKAGE DIMENSIONS



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	STANDARD: NON-JEDEC	
	27 AUG 2013	



VIEW Y-Y

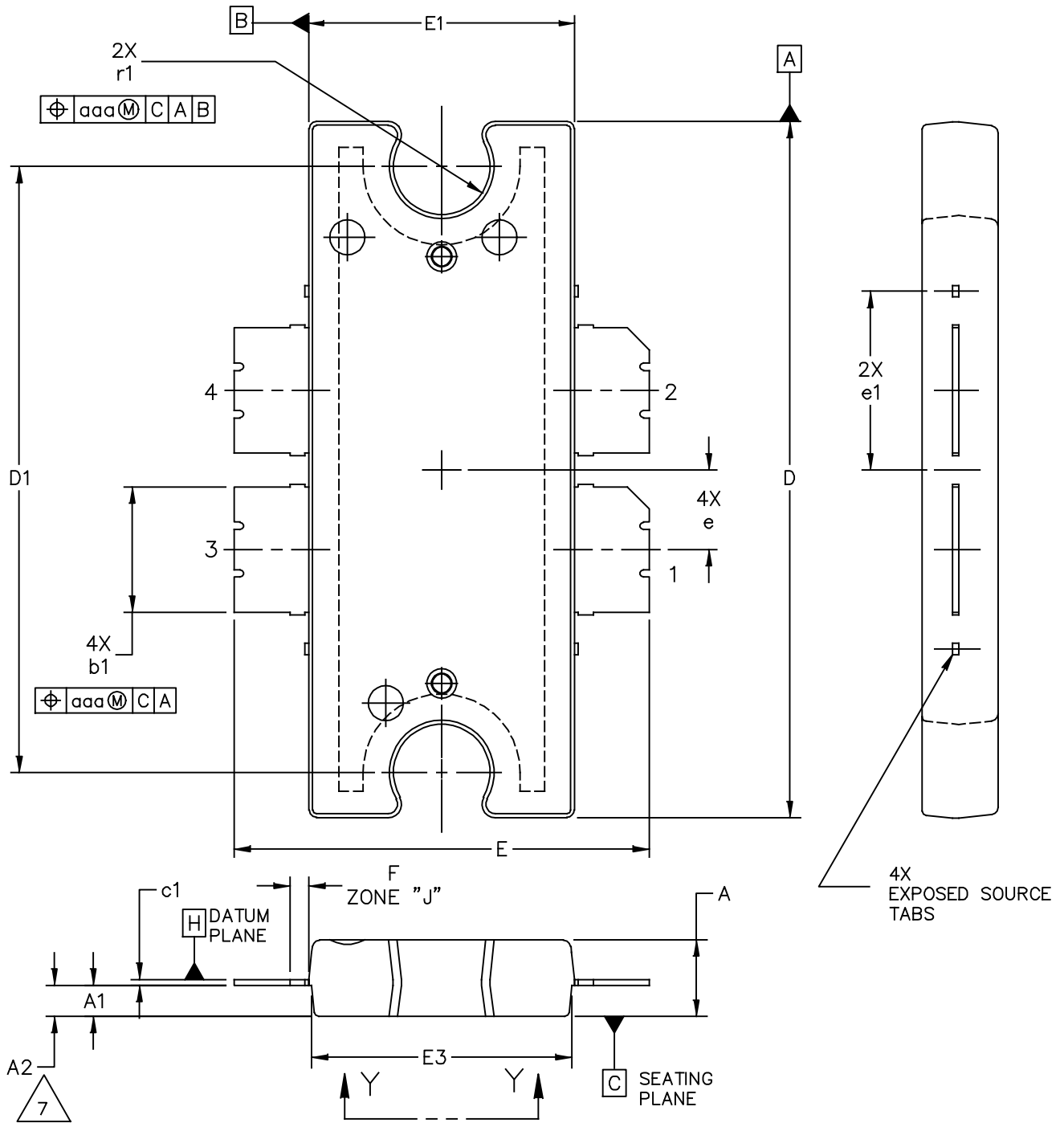
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MMRF1018NR1 MMRF1018NBR1

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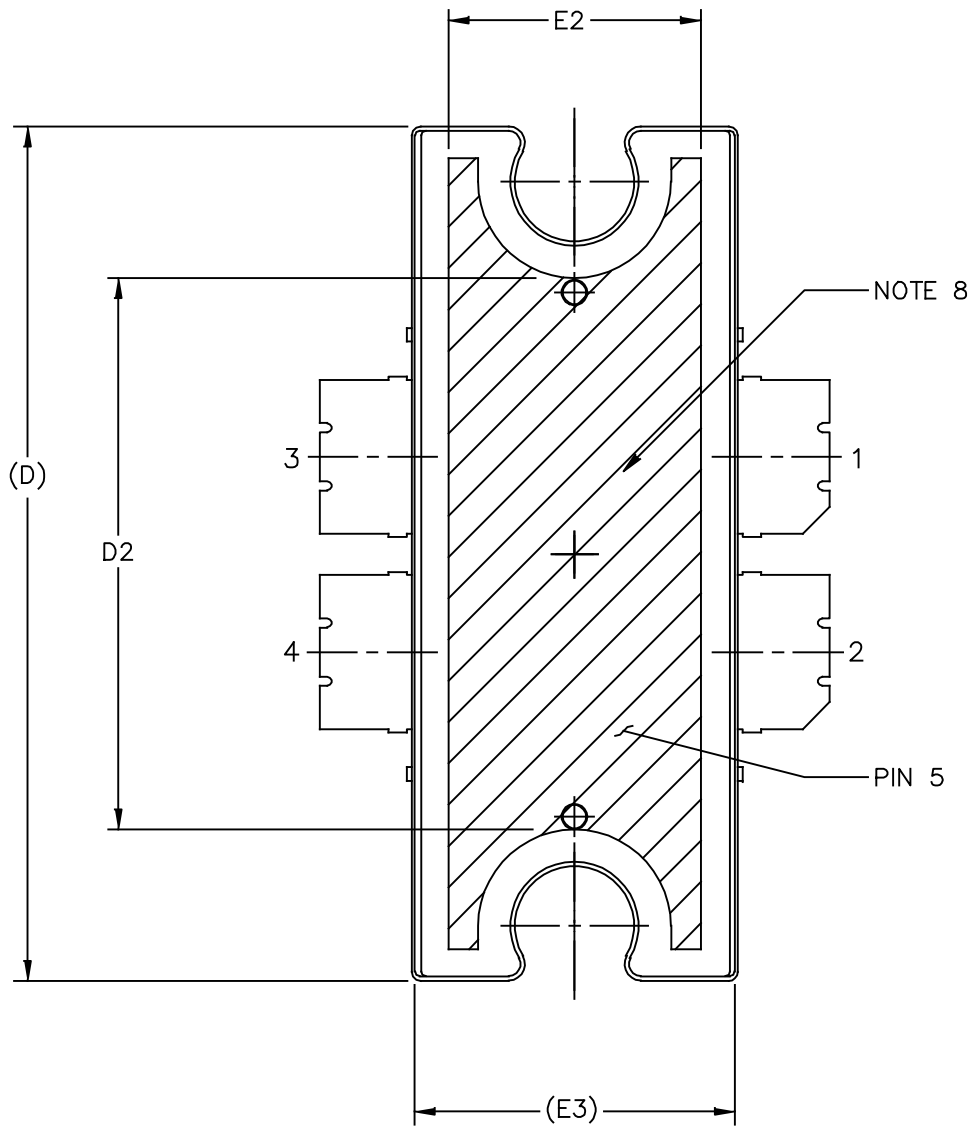
1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 INCH (0.15MM) PER SIDE. DIMENSIONS D1 AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSIONS b1 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 INCH (0.13MM) TOTAL IN EXCESS OF THE b1 DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSION A2 APPLIES WITHIN ZONE J ONLY.
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. DIMENSIONS D3 AND D4 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.
9. DIMPLED HOLE REPRESENTS INPUT SIDE.
10. THESE SURFACES OF THE HEAT SLUG ARE NOT PART OF THE SOLDERABLE SURFACES AND MAY REMAIN UNPLATED.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	.100	.104	2.54	2.64	F	.025 BSC		0.64 BSC	
A1	.039	.043	0.99	1.09	b1	.164	.170	4.17	4.32
A2	.040	.042	1.02	1.07	c1	.007	.011	0.18	0.28
D	.712	.720	18.08	18.29	e	.106 BSC		2.69 BSC	
D1	.688	.692	17.48	17.58	e1	.239 INFO ONLY		6.07 INFO ONLY	
D2	.011	.019	0.28	0.48	aaa	.004		0.10	
D3	.600	---	15.24	---	bbb	.008		0.20	
E	.551	.559	14.00	14.20					
E1	.353	.357	8.97	9.07					
E2	.132	.140	3.35	3.56					
E3	.124	.132	3.15	3.35					
E4	.270	---	6.86	---					
E5	.346	.350	8.79	8.89					
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TITLE:  TO-270WB-4					DOCUMENT NO: 98ASA10577D      REV: E				
					STANDARD: NON-JEDEC				
					27 AUG 2013				



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			CASE NUMBER: 1484-04		31 AUG 2007
			STANDARD: NON-JEDEC		

MMRF1018NR1 MMRF1018NBR1



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TITLE: TO-272 4 LEAD, WIDE BODY	DOCUMENT NO: 98ASA10575D	REV: E	
	CASE NUMBER: 1484-04	31 AUG 2007	
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NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS "D" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D" AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSIONS "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.
8. HATCHING REPRESENTS EXPOSED AREA OF THE HEAT SLUG. HATCHED AREA SHOWN IS ON THE SAME PLANE.

STYLE 1:

PIN 1 - DRAIN      PIN 2 - DRAIN  
 PIN 3 - GATE      PIN 4 - GATE  
 PIN 5 - SOURCE

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	.100	.104	2.54	2.64	b1	.164	.170	4.17	4.32
A1	.039	.043	0.99	1.09	c1	.007	.011	.18	.28
A2	.040	.042	1.02	1.07	r1	.063	.068	1.60	1.73
D	.928	.932	23.57	23.67	e	.106 BSC		2.69 BSC	
D1	.810 BSC		20.57 BSC		e1	.239 INFO ONLY		6.07 INFO ONLY	
D2	.600	---	15.24	---	aaa	.004		.10	
E	.551	.559	14	14.2					
E1	.353	.357	8.97	9.07					
E2	.270	---	6.86	---					
E3	.346	.350	8.79	8.89					
F	.025 BSC		0.64 BSC						

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## PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

### Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Over-Molded Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN3263: Bolt Down Mounting Method for High Power RF Transistors and RFICs in Over-Molded Plastic Packages
- AN3789: Clamping of High Power RF Transistors and RFICs in Over-Molded Plastic Packages

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTF Calculator

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	July 2014	• Initial Release of Data Sheet

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